

Bridging the gap between large and small scales in astronomical images through simultaneous modeling of point-like and diffuse emission

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Introduction

- Millimeter observations are sensitive to a variety of astrophysical/cosmological emission components
- Many analyses are confronted with data where only the joint observed emission is available
 - Measuring point source properties in presence of primary CMB anisotropies
 - In the sub-mm, inference of extragalactic and galactic point sources in the presence of galactic cirrus
 - Galaxy cluster observations are contaminated by all of the above (at different observing frequencies)



Challenges of modeling (out) diffuse emission

- Left uncorrected, diffuse emission can bias source photometry and degrade source detection
- High-pass/derivative filtering techniques attenuate and distort signal of interest
- Depending on the level of diffuse emission, choosing an "optimal" filtering scale can be complicated/ambiguous
- Component separation through spectral information is often not possible





Probabilistic cataloging

- Standard cataloging approaches are ill-equipped to perform accurate point source inference in crowded stellar fields, confusion-limited data
- Probabilistic cataloging (PCAT) is a forward modeling approach to cataloging that alleviates biases in point source photometry by exploring the posterior distribution of all catalogs consistent with an observed image
- Initially proposed in Brewer et *al.* 2013, further developed by Daylan et *al.* 2017a,b; Portillo et *al.* 2017; Feder et *al.* 2019 on various astronomical datasets

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Probabilistic cataloging

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PCAT posterior catalog model realizations of Herschel-SPIRE 250µm image cutout of GOODS-N deep field



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PCAT is a... Bayesian hierarchical model



Extending PCAT to model diffuse emission

To model diffuse structured emission, we employ a flexible 2D truncated Fourier series model, where each Fourier component is represented by an image space template. This can be written as:

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$$B_{lm} = B_0 + \sum_{k=1}^{N_m} \sum_{j=1}^{N_m} \boldsymbol{\beta}_{kj} \cdot \boldsymbol{\mathcal{F}}_{lm}^{kj}$$

where

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$$\boldsymbol{\mathcal{F}}_{lm}^{kj} = \begin{pmatrix} \sin\left(\frac{k\pi l}{W}\right)\sin\left(\frac{j\pi m}{H}\right)\\ \sin\left(\frac{k\pi l}{W}\right)\cos\left(\frac{j\pi m}{H}\right)\\ \cos\left(\frac{k\pi l}{W}\right)\sin\left(\frac{j\pi m}{H}\right)\\ \cos\left(\frac{k\pi l}{W}\right)\cos\left(\frac{j\pi m}{H}\right) \end{pmatrix}$$



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Separating point-like and diffuse emission



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Separating point-like and diffuse emission









Separating point-like and diffuse emission







Measuring the tSZ effect using Herschel-SPIRE image data

SZ effect



Instrument noise





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Measuring the tSZ effect using Herschel-SPIRE image data

0.004

0.002

-0.004

-0.006

SZ effect

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Instrument noise



Cirrus

CIB



0.025 [] 0.020 [] 0.020 []





Measuring the tSZ effect using Herschel-SPIRE image data



By using SPIRE data from the higher resolution 250 µm passband, the various emission components can be jointly modeled and deblended at longer wavelengths, where the SZ distortion is larger.



Measuring the tSZ effect using Herschel-SPIRE image data



Data likelihood:



Model priors: $\{\pi(f_0), \pi(s), \pi(x, y), \pi(N_{src})\}$ $\pi(\mathbf{B}(\nu_b))$



Cirrus contamination in RX J1347.5-1145

Median Nsrc = 470



Purple region indicates location of SZ signal, for visualization only

Best fit Planck cirrus model





Cirrus contamination in RX J1347.5-1145

Median Nsrc = 385



Purple region indicates location of SZ signal, for visualization only

Best fit Fourier cirrus model (6th order)





Recovery of the tSZ effect from *Herschel*-SPIRE clusters

- CIB model from Bethermin et al. 2013 used to generate set of mock SPIRE observations
- When testing on unlensed realizations of the CIB, our pipeline yields unbiased estimates of the SZ effect
- Strong gravitational lensing leads to an overall surface brightness deficit near the cluster center, biases SZ template estimation (addressed in Butler+Feder et *al.* 2021, in prep.)



Aggregate posteriors from 100 mock CIB realizations



Recovery of the tSZ effect from *Herschel*-SPIRE clusters





Conclusion

- The incorporation of a flexible Fourier component model to PCAT shows promise for analyzing clusters and cataloging fields with moderate amounts of dust contamination, or removal of point sources from a foreground/background of interest (see Feder et *al* 2021, in prep.)
- PCAT's Bayesian forward modeling framework naturally accommodates more detailed SZ emission models
- While cirrus dust is the diffuse emission source considered in this work, PCAT-*DE* may be applied to other situations, e.g., residual atmospheric fluctuations from ground-based observations
- Current implementation can be found at <u>https://github.com/RichardFeder/multiband_pcat</u>. Tutorials/examples coming soon!

Thank you!



Extra slides



PCAT is a... transdimensional sampler







Modified Proposal Steps/Acceptance Ratios

6

Source flux prior decomposition:

$$\pi(\vec{f}) = \pi(f_1) \times \prod_{i=2}^k \pi(s_i)$$

Merge/Split Acceptance Factor

$$\alpha_{split} = \frac{2\pi k^2}{A} \frac{\pi_1(f_1)\pi_2(f_1)}{\pi_0(f_1)q(F_1)} \prod_i \frac{\pi_1(s_i)\pi_2(s_i)}{\pi_2(s_i)q(F_i)} \mathcal{J}_i$$
$$\mathcal{J} = \prod_{i=1}^n \frac{2.5}{\log(10)} \frac{1}{F_i(1-F_i)}$$



Completeness/false discovery rate vs. F.C. order





Dependence of lensing bias on injected SZ signal



Diffuse background data, Fourier component model

Order of Fourier component model = 5



Diffuse background data, Fourier component + point source model

Order of Fourier component model = 5

